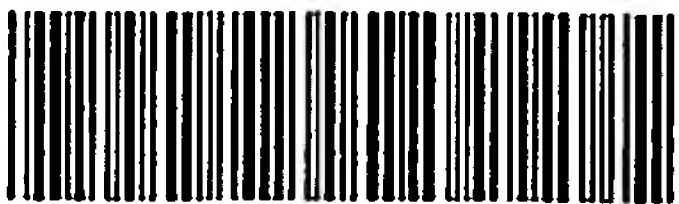


Search Notes



Application/Control No.

10/710,383

Examiner

Nguyen N. Hanh

Applicant(s)/Patent under
Reexamination

YAMADA, TAKASHI

Art Unit

2834

SEARCHED

| Class | Subclass | Date | Examiner |
|------------------|-----------------------|----------|----------|
| 310 | 194 | 6/7/2005 | HN |
| 310 | 71 | 6/7/2005 | HN |
| 310 | 258 | 6/7/2005 | HN |
| 310 | 259 | 6/7/2005 | HN |
| 310 | 216 316 | 6/7/2005 | HN |
| 310 | 217 | 6/7/2005 | HN |
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| 310 | 194 | 8/15/05 | HN |
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
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| consult Dang Le, Primary Examiner for allowance | 6/7/05 | HN |
| PG PUB text search 8/15/05, see interference search printout | - | HN |
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